



Dual N-Channel 20-V (D-S) MOSFET

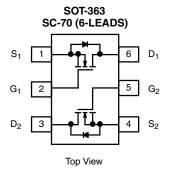
PRODUCT SUMMARY					
V _{DS} (V)	r _{DS(on)} (Ω)	I _D (A)			
20	0.385 at $V_{GS} = 4.5 \text{ V}$	0.70			
	0.630 at V _{GS} = 2.5 V	0.54			

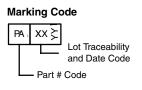
FEATURES

TrenchFET[®] Power MOSFETS: 2.5 V Rated



RoHS COMPLIANT





Ordering Information: Si1902DL-T1 (with Tape and Reel) Si1902DL-T1-E3 (Lead (Pb)-free with Tape and Reel)

ABSOLUTE MAXIMUM RATINGS $T_A = 25$ °C, unless otherwise noted						
Parameter		Symbol	5 secs	Steady State	Unit	
Drain-Source Voltage		V _{DS}	20		V	
Gate-Source Voltage		V_{GS}	±12			
Continuous Proin Comment /T 450 00\8	T _A = 25 °C		0.70	0.66		
Continuous Drain Current (T _J = 150 °C) ^a	T _A = 85 °C	Ι _D	0.50	0.48		
Pulsed Drain Current		I _{DM}	1.0		Α	
Continuous Source Current (Diode Conduction) ^a		I _S	0.25	0.23		
Maximum Power Dissipation ^a	T _A = 25 °C	P _D	0.30	0.27	W	
	T _A = 85 °C	' D	0.16	0.14	VV	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 150		°C	

THERMAL RESISTANCE RATINGS					
Parameter		Symbol	Typical	Maximum	Unit
Manianum lumation to Ambient	t ≤ 5 sec	R _{thJA}	360	415	°C/W
Maximum Junction-to-Ambient ^a	Steady State		400	460	
Maximum Junction-to-Foot (Drain)	Steady State	R_{thJF}	300	350	

a. Surface Mounted on 1" x 1" FR4 Board.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply

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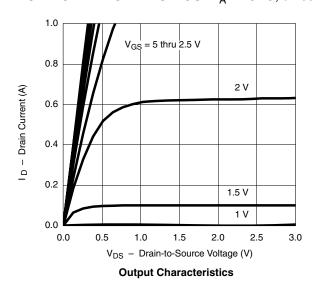
Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit	
Static							
Gate Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	0.6		1.5	V	
Gate-Body Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 12 \text{ V}$			± 100	nA	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 16 V, V _{GS} = 0 V	1		1		
		V _{DS} = 16 V _{GS} = 0 V, T _J = 85°C	5			μA	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 4.5 \text{ V}$	1.0			Α	
Drain-Source On-State Resistance ^a		$V_{GS} = 4.5 \text{ V}, I_D = 0.66 \text{ A}$		0.320	0.385		
	r _{DS(on)}	$V_{GS} = 2.5 \text{ V}, I_D = 0.40 \text{ A}$		0.560	0.630	Ω	
Forward Transconductance ^a	9 _{fs}	$V_{DS} = 10 \text{ V}, I_D = 0.66 \text{ A}$		1.5		S	
Diode Forward Voltage ^a	V_{SD}	$I_S = 0.23 \text{ A}, V_{GS} = 0 \text{ V}$		0.8	1.2	V	
Dynamic ^b							
Total Gate Charge	Q_g			0.8	1.2		
Gate-Source Charge	Q_{gs}	$V_{DS} = 10 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 0.66 \text{ A}$		0.06		nC	
Gate-Drain Charge	Q_{gd}			0.30			
Turn-On Delay Time	t _{d(on)}			10	20		
Rise Time	t _r	$V_{DD} = 10 \text{ V}, R_1 = 20 \Omega$		16	30	ns	
Turn-Off DelayTime	t _{d(off)}	$I_D\cong 0.5$ A, V_{GEN} = 4.5 V, R_G = 6 Ω		10	20		
Fall Time	t _f			10	20		
Source-Drain Reverse Recovery Time	t _{rr}	$I_F = 0.23 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}$		20	40		

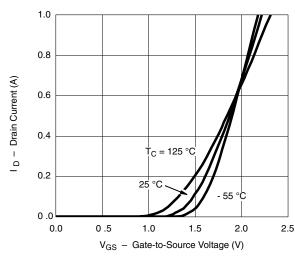
Notes:

- a. Pulse test; pulse width \leq 300 µs, duty cycle \leq 2 %.
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

TYPICAL CHARACTERISTICS $T_A = 25$ °C, unless otherwise noted





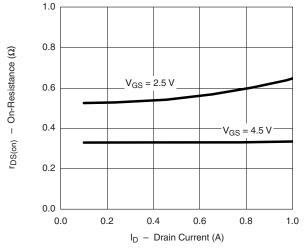
Transfer Characteristics



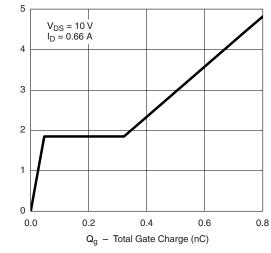
V_{GS} - Gate-to-Source Voltage (V)

- Source Current (A)

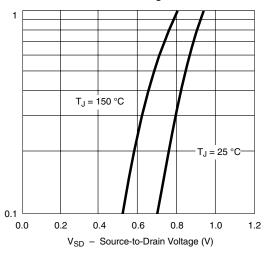
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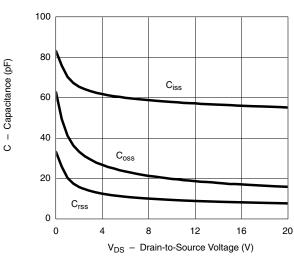
On-Resistance vs. Drain Current



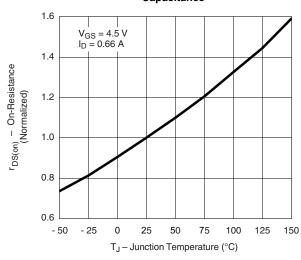
Gate Charge



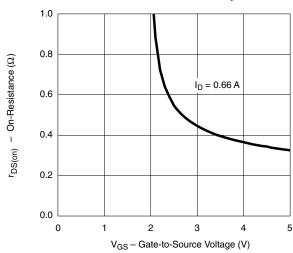
Surge-Drain Diode Forward Voltage



Capacitance



On-Resistance vs. Junction Temperature

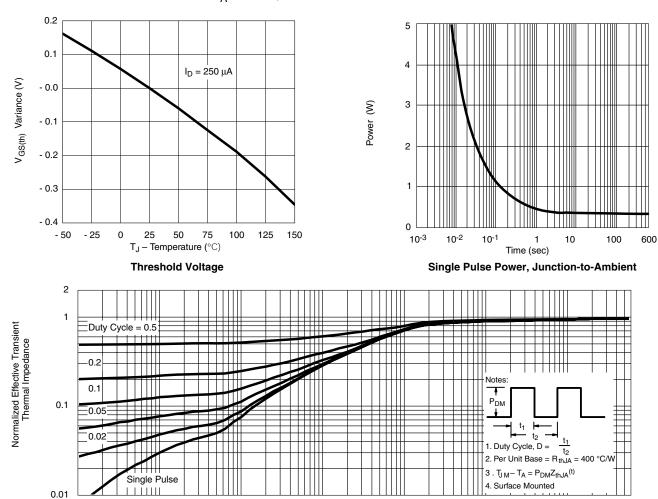


On-Resistance vs. Gate-to-Source Voltage

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TYPICAL CHARACTERISTICS $T_A = 25$ °C, unless otherwise noted



Square Wave Pulse Duration (sec)

Normalized Thermal Transient Impedance, Junction-to-Ambient

10

100

600

10⁻¹

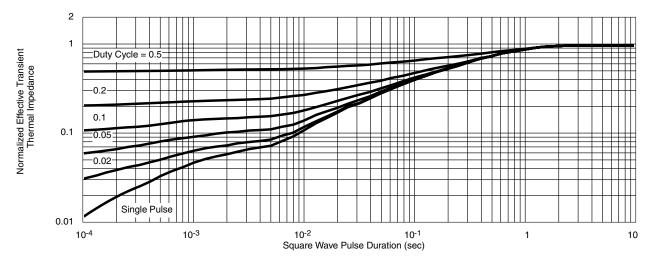
1 0 -2

10-3

10⁻⁴



TYPICAL CHARACTERISTICS $T_A = 25$ °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Foot

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Revision: 18-Jul-08

Document Number: 91000 www.vishay.com